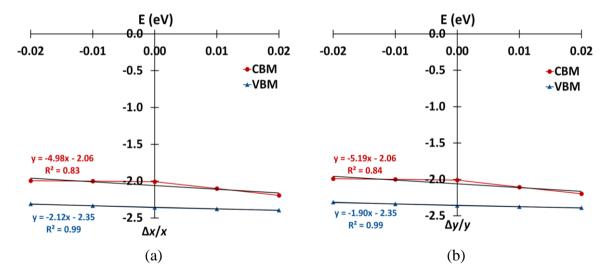
Supplementary file

Designing type-II SnSSe/As van der Waals heterostructure with satisfactory oxygen tolerance as an efficient absorber material

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S1 Band energies of the CBM and VBM for SnSSe/As heterostructure as a function of lattice dilation along x and y directions. The fitted slopes show the E_D in eV.

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S2 SLME computational details

Theoretical maximum solar cell efficiency can be calculated using the following formula:

$$\eta = \frac{P_{\rm m}}{P_{\rm in}}$$

where P_m is the highest achievable power density of the thin-film solar absorber material, while P_{in} is the incident power density of the entire solar spectrum. The maximum output power density P=JV of the material can be found utilizing J-V characteristics of solar cell as proposed by Yu and Zunger [1]. Here, J indicates the total current density, while V represents the potential over the absorber layer, as seen in the following relationship:

$$J = J_{sc} - J_r \left(e^{eV/k_B T} - 1 \right)$$

in which J_{sc} , J_r , k_B and T denote, respectively, the short-circuit current, the total recombination current density, the Boltzmann constant, and the temperature. Absorptivity $\alpha(E)$, photon flux from incident solar spectrum $I_{sun}(E)$ (AM1.5G) and black-body spectrum $I_{bb}(E,T)$ can be used to calculate J_{sc} and J_r , as follows:

$$J_{sc} = e \int_0^\infty \alpha(E) I_{sun}(E) dE$$

$$J_{\rm r} = e \int_0^\infty \alpha(E) I_{\rm bb}(E, T) dE$$

where $\alpha(E)$ and L are the absorbance coefficient and thickness of the thin film, respectively. Total recombination current density is largely contributed by radiative recombination current density J_{rad} and non-radiative recombination current density $J_{non-rad}$.

[1] L. Yu and A. Zunger (2012). Identification of Potential Photovoltaic Absorbers Based on First-Principles Spectroscopic Screening of Materials. Phys. Rev. Lett. 108, 068701.